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A Novel Approach to Augment the Opto-Electronic Properties of Stannic Oxide (SnO₂) Thin Films by Vanadium Doping

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ARTICLEINFO	ABSTRACT
Article history: Received: 28 August, 2020 Accepted: 23 October, 2020 Online: 08 November, 2020	The Tin Oxide: Vanadium (SnO ₂ : V) thin films have been deposited on glass substrates with various Vanadium concentration at a substrate temperature; 500°C using microprocessor-controlled spray pyrolysis technique. The structural, compositional, morphological and optical analyses of the samples are characterized by XRD, EDAX, SEM and UV-Visible
Keywords: Doping Concentration Optical Properties SnO ₂ Thin films Spray Pyrolysis	spectroscopy. The XRD analysis shows tetragonal rutile structure formation in lattice configuration of virgin and Vanadium doped SnO ₂ thin films. The uniform crystallinity is appeared on the surface of crystal and it is proved by extreme diffraction peak for 3at% Vanadium doped SnO ₂ thin films. The optical transmittance increases from virgin to 3at% with increase in doping concentration. The transmittance for 4at% is minimum compared with 3at% of vanadium doping. The FTIR analysis illustrates the bond formation between Sn-O and V-O respectively. This also validates the strong force constant for the consistent crystal structure.

1. Introduction

Thin film technologies paved the way of preparing the most promising material [Transparent conducting oxides] in optical energy controlled electronic devices; solar cells, displays, optoelectronic interfaces devices and electronic-circuitries, owing to its properties such as electrically conductive nature with high transmittance of light [1]. The accomplishment of such properties is performed by successive doping with wide-band gap optical semiconductors ($E_g > 3.1$ eV) and are pivoted to advanced technologies[2-5]. In₂O₃ is considered to be the leading TCO in concerned with their properties as well as its commercial success. However, ITO is playing a major role in electronics market; it is of high cost and limited availability [6-9]. SnO₂ is economically cheap compared to indium oxide. It is an ideal candidate for many applications. Its high chemical stability is considered to be an inherent advantage of SnO₂ [10] and it makes SnO₂ appreciably adoptable for applications in challenging atmosphere, for preparing transparent and strong-conductive electrode on photo enabled electrodes or as a selectively solar energy penetration coating [11, 12]. Its applications include surface coatings, environmental and human health [13] gas sensors [14] organic

pollutants and toxic water [15] and heterojunction catalysts [16], Tin dioxide (SnO₂), having lattice parameters a = b = 4.737 Å and c = 3.826 Å with tetragonal Rutile structure is an important n-type semiconductor. Each tin atom at the corners of a regular octahedron is bounded to six oxygen atoms and three tin atoms surround each oxygen atom [17]. High ability to let incoming radiation in the UV region, high reflectance in the IR region, high electrical conductivity, high melting temperature, harmless nature, easy doping and plenty in nature. These are the remarkable characteristics of SnO₂ [18]. For optoelectronic devices and solar cell applications, SnO₂ thin films is a very suitable candidate as it is having a good electrical and optical properties [19].

Many research investigations have been performed on heavily doped and rather doped tin oxide thin films using various available techniques [20-22]. Although there are several techniques for deposition, spray pyrolysis technique is the most preferred technique due to its simplicity, low cost and for large area coating [23]. Doping with certain p block and d block elements augments the light sensitive properties and the ability of transmitting electricity of SnO₂ thin films [24]. As the ionic radius of Vanadium (V4⁺/Sn4⁺ = 0.58/0.71Å) is smaller than the host Sn4⁺, it can be easily doped into SnO₂ [25]. After screening the literatures, it is revealed that, few researches have analyzed the

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properties of Vanadium fused SnO_2 thin films [26-28], it is of particular interest to deposit Vanadium doped SnO_2 thin films by micro controller-assembled spray pyrolysis technique. In the present work, the Vanadium doped SnO_2 thin films have been characterized and they are investigated according to the operated properties. As a first step SnO_2 : V thin films are synthesized. Then structural and light sensitive properties of the customized thin-films are keenly observed and the data is validated. This work intends to improve the characteristics of SnO_2 thin films by doping Vanadium at different concentration.

2. Experimental methods

2.1. Synthesis of vanadium doped SnO₂ thin films

In the blended mixture of doubly de-ionized water and intensive solvent; methanol in the ratio 1:1, the precursor material $SnCl_4.5H_2O$ (Tin (IV) Chloride Pentahydrate) (35.06g) is dissolved to obtain 0.1M starting solution and few drops of hydrochloric acid is added to get a clear solution. To the precursor, well grained powder V_2O_5 (Vanadium Pentoxide) is added in the ratio of 0,1,2,3&4at% (0g, 0.509g, 1.018g, 1.527g, 2.036g). A reservoir filled with precursor solution is mounted on stand. The area of the substrate is $2.5x7.5cm^2$ (optically flat glass slides). Formerly cleaning of the substrates are achieved using hydrochloric acid, non-polar solvent; acetone and sterilized water by suitable ultrasonic cleaner for 35 minutes to terminate organic substance and another contaminant from the surface.

The micro controller-operated spray pyrolysis set up is displayed in Figure1. It consists of a syringe needle having the diameter of 0.6mm connected to the reservoir and its height can be altered to get 0.002mL/Min at the needle tip. Distance of 8cm is kept between the needle and the surface of the substrate. Substrate attracts the precursor solution as high voltage of about (9.65KV) is applied between needle and hot-plate. To optimize the thickness (500nm) different volume of precursor solution is sprayed and the dimensions between the two surfaces of all the sprayed samples are verified using standard method. A timer is connected to high voltage power supply, relay and hot plate. The timer is set in such a way that when hot plate is on, high voltage will be in off condition and vice-versa. The charge presents in substrate holder and svringe needle, substrate temperature, heat inside the chamber are controlled by means of relay, thermocouple arrangement and exhaust fan. The distance of the syringe needle is adjusted up and down to obtain a continuous thin film. In the experiment, five sequential sets of undoped and Vanadium doped SnO₂ thin films are fabricated by controlling the substrate temperature at 500°C. The optimized time allotment for deposition for each sample is determined as 44minutes by counting the spray intervals of time. The alternating spray process is employed for this study at a spray for 5seconds and an interval of 10seconds for each cycle.

2.2. Characterization Technique

In our present study the surface morphology of the prepared samples is characterized by employing scanning electron microscope (CARLZEISS) shown in Figure 2. The compositional details are analyzed by (EDAX) technique. The lattice parameters are examined by X-ray diffractometer (SHIMADZU-XRD 6000) (Cu–Ka) of wavelength 1.520Å. The profilometer is used to find the dimension between two surfaces of the films by making suitable stylus technique at four different areas on the outside of film and the average dimension is found to be around 500 nm. Weight gain method is also used to find the thickness. The optical absorption and translucence of the films are measured in the wavelength range of 300–1100nm using a Unico 4802 UV–Vis double beam spectrophotometer. FTIR spectra are recorded by means of SHIMADZU1800-UV Fourier transform infrared spectrometer.



Figure 1: Schematic diagram of the Home-made spray pyrolysis setup.



Figure 2: Carl Zeiss scanning electron microscope.

3. Results and Discussion

3.1. Structural properties

Figure 3 shows the XRD spectra of virgin and Vanadium doped SnO_2 thin films. The highest diffraction peaks are (110), (101), (200), (211), (220). The coincidence of diffracted peaks with tetragonal structure of SnO_2 (JCPDS card number: 41-1445) is observed for all the recorded peaks of Vanadium doped SnO_2 thin films [29]. No phase consistent to the dopant or other compound is observed. Though the doping level of Vanadium is increased from 1at% to 3at%, Vanadium oxide phases are not

dominated in Vanadium operated SnO_2 films. The intensity of the peak corresponding to the predominant plane (110) in the primary phase is increased on Vanadium doping until 3at% and further addition of 1at% doping concentration, the intensity decreases due to the exchange of Sn4^+ ions with Vanadium ions in the lattice of SnO_2 film, whereas the intensity of the plane (211) in the secondary phase rapidly increases with increase in the concentration of Vanadium. This shows better atomic arrangement and lower scattering in these planes. The structural analysis is done for the predominant peak and the results are given in Table 1. The optimized crystallite size of virgin SnO_2 and doped SnO_2 films for all the dopant levels are calculated using Debye-Scherrer formula [30]

$$D = K\lambda/\beta \cos\theta \tag{1}$$

where D is the mean crystallite size, K is a particle size dependent constant whose value is 0.9, λ is the diffraction wavelength of CuKa ($\lambda = 1.5406$ Å). β is the full width at half maximum (FWHM) and θ is the diffracted angle. The lattice parameters and crystallite size for the predominant peak (110) of the prepared samples are given in Table1. It is confirmed that the increase in the concentration of Vanadium from 0 to 4at% results in the range of crystallite size from 55.72nm to 41.79nm. The decrease in crystallite size may be due to the density enrichment in the nucleation centers of the doped samples and also may be due to lattice distortion. For further addition of 1at% Vanadium, dopant dominates the crystalline size.



Figure 3: XRD Pattern of undoped and V (1at%, 2at%, 3at%, 4at%) doped SnO₂ thin films.

Table 1: Doping concentration ratio (1at%, 2at%, 3at%, 4at%) for SnO₂ thin films.

Predominant peak	Angle2θ (degree)	d spacing (Å)	FWHM	Crystallite size (nm)
Undoped (110)	26.806	3.3232	0.153	55.72
1at%V (110)	26.908	3.3107	0.180	47.37

2at%V (110)	26.932	3.3079	0.175	48.73
3at%V (110)	26.793	3.3248	0.204	41.79
4at%V (110)	26.748	3.3302	0.172	49.76

3.2. Morphological Analysis

The surface morphology of virgin and Vanadium doped SnO₂ thin films deposited at a temperature of 500°C with different Vanadium content concentration are shown in Figure 4. The SEM image of virgin SnO₂ exhibits smaller grains. It is evident from the images that the surface morphology reveals significant changes on doping [31]. For 1at% of Vanadium doped SnO₂ thin film, molecules of different morphology and sizes are formatted due to inadequate Vanadium doping. Grain size decreases when doping concentration of Vanadium increases [32]. This is observed in the SEM image for 2at% Vanadium doped SnO₂ thin film. A film having superior quality with uniform grains as proved by structural analysis is observed for 3at% Vanadium doped SnO₂ thin film. A bove 3at% of the dopant concentration, grains are found to increase in its size and appear with small sized grains in between large sized grains.



Figure 4: SEM images of undoped and V (1at%, 2at%, 3at%, 4at%) doped SnO₂ thin films.

3.3. Elemental analysis

From the EDAX analysis recorded in Figure 5. The consistent peaks Sn, V and O are observed in the EDAX pattern of all the Vanadium doped samples. For all V-doped SnO₂ samples the existence of Vanadium is also detected. Both vanadium extent and relative intensity are directly proportional to each other.

3.4. Optical properties

Optical transmittance spectra of virgin and Vanadium doped SnO_2 thin films are shown in Figure 6. In the visible region (400–700 nm), the observed translucence is about ~60–80%. For virgin SnO_2 thin film transmittance is minimum compared to the vanadium doped SnO_2 thin film. Transmittance increases with dopant concentration. Increase in transmittance may be due to the

improved crystallinity of the film. In our results, transmittance increases from virgin to 3at% with increase in dopant concentration. Transmittance decreases with further 1at% of Vanadium doping. The decrement of optical transmittance is made due to the increment of particle size and it is evidenced from the SEM image and also may be due to the crystal defects created by doping.



Figure 5: EDAX analysis spectra of undoped and V (1at%, 2at%, 3at%, 4at %) doped SnO₂ thin films.



Figure 6: Transmittance spectra of undoped and V (1at%, 2at%, 3at%, 4at %) doped SnO₂ thin films.

The observed absorbance modulated spectra of virgin SnO₂ and Vanadium doped SnO₂ thin films at different concentrations are depicted in Figure 7. Gradually increasing absorption from NIR to the visible region is observed. The absorption edge is prolonged to the visible region due to the fusion of Vanadium ions into SnO₂ ions. A substantial red-shift is absolutely observed on the increment in doping attentiveness of vanadium species [33]. Absorption band edge of the films is observed by the calculated first derivative of the optical transmittance. The band gap is an important property which determines the quality of the deposited thin films. In Figure 8, the curves of dT/d λ vs hv have been drawn and showed the stress of doping on the direct optical band gap (Eg).The band gap values are observed to be ranged from 2.970 eV to 3.130 eV. There is fluctuation in band gap energies with doping concentrations of Vanadium. High value of band gap

energy is a result of lower-quality films. In the present case good quality film is obtained in 3at% of Vanadium doping concentration.



Figure 7: Absorption spectra of undoped and V (1at%, 2at%, 3at%, 4at%) doped SnO₂ thin films.



Figure 8: Plot of dT/dλ vs. (hv) for undoped and V (1at%, 2at%, 3at%, 4at%) doped SnO₂ thin films.

3.5. FTIR analysis

Figure 9 displays the FT-IR spectra of virgin and Vanadium doped SnO₂ thin films fabricated by microprocessor-controlled spray pyrolysis method. As the present case is inorganic compound, all the IR peaks are concentrated in the region of 200-1200cm⁻¹. Particularly, the stretching, in plane and out of plane bending modes for Sn-O bond are observed at 750, 740 and 710cm⁻¹, the in plane bending modes are found at 400, 380 and 360cm⁻¹ and the out of plane bending modes are occupied at 280, 260 and 250cm⁻¹. All the observed bands are validated by the literatures [34]. The V-O bond stretching, bending modes are determined at 610, 320 and 210cm⁻¹. All the spectroscopical impressions illustrate the strong coupling of V on SnO₂ configuration.



Figure 9: FTIR spectra of undoped and V (1at%, 2at%, 3at%, 4at%) doped SnO₂ thin films.

4. Conclusions

In this work, the popular heavy metal species Vanadium is doped on SnO₂crystal material and it is formed as thin films with the doping concentration of 1at%, 2at%, 3at% and 4at% respectively. The compositional, morphological, structural and optical analysis is made on samples and the results are discussed. From the observed data, the optimized state of doping concentration is found to be 3at%. The vibrational study is confirmed the active presence of strong bonds such as Sn-O and V-O. The presence of Sn-O-V bonds and angles are also validated from the complex form of vibrational bands. The film at doping of 3at % is having superior quality with uniform grains as proved by structural. From the optical studies, it is revealed that, the optical intensive transmittance increases from virgin to doped SnO2 at 3at% which leads to the decrement of band gap energy. The acquired results from structural, morphological, vibrational and optical studies demonstrated the effectiveness of doped thin film.

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